

Notice of References Cited

Application/Control No.

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Reexamination

FUNAKAWA ET AL.

Examiner

MARCUS T. RILEY

Art Unit

2625

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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,069,706 A	05-2000	Kajita et al.	358/1.15
*	B US-6,538,764 B2	03-2003	Ueda, Shigeru	358/1.16
*	C US-6,687,742 B1	02-2004	Iwazaki, Ryuji	709/206
*	D US-7,268,902 B2	09-2007	Hino, Yasuhiro	358/1.15
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	JP 05130343 A	05-1993	Japan	KONDO, MASAYA	H04N 01/21
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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